# 40 V, 8.0 A, Low V<sub>CE(sat)</sub> **NPN Transistor**

ON Semiconductor's e<sup>2</sup>PowerEdge family of low V<sub>CE(sat)</sub> transistors are miniature surface mount devices featuring ultra low saturation voltage (V<sub>CE(sat)</sub>) and high current gain capability. These are designed for use in low voltage, high speed switching applications where affordable efficient energy control is important.

Typical applications are DC-DC converters and power management in portable and battery powered products such as cellular and cordless phones, PDAs, computers, printers, digital cameras and MP3 players. Other applications are low voltage motor controls in mass storage products such as disc drives and tape drives. In the automotive industry they can be used in air bag deployment and in the instrument cluster. The high current gain allows e<sup>2</sup>PowerEdge devices to be driven directly from PMU's control outputs, and the Linear Gain (Beta) makes them ideal components in analog amplifiers.

• This is a Pb-Free Device

## MAXIMUM RATINGS (T<sub>A</sub> = 25°C)

Rating	Symbol	Max	Unit
Collector-Emitter Voltage	V <sub>CEO</sub>	40	Vdc
Collector-Base Voltage	V <sub>CBO</sub>	40	Vdc
Emitter-Base Voltage	V <sub>EBO</sub>	6.0	Vdc
Collector Current - Continuous	Ι <sub>C</sub>	6.0	Adc
Collector Current - Peak	I <sub>CM</sub>	8.0	A
Electrostatic Discharge	ESD	HBM Class 3B MM Class C	

Characteristic	Symbol	Мах	Unit
Total Device Dissipation, $T_A = 25^{\circ}C$ Derate above $25^{\circ}C$	P <sub>D</sub> (Note 1)	830 6.7	mW mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 1)	150	°C/W
Total Device Dissipation, $T_A = 25^{\circ}C$ Derate above $25^{\circ}C$	P <sub>D</sub> (Note 2)	1.4 11.1	W mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 2)	90	°C/W
Thermal Resistance, Junction-to-Lead #1	$R_{\theta JL}$ (Note 2)	15	°C/W
Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C

### THERMAL CHARACTERISTICS

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

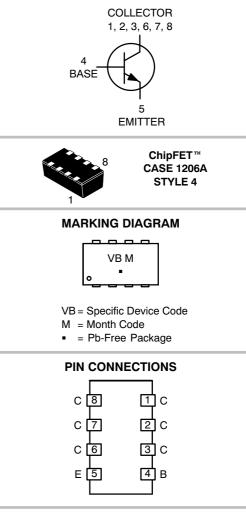
FR-4 @ 100 mm<sup>2</sup>, 1 oz copper traces.
 FR-4 @ 500 mm<sup>2</sup>, 1 oz copper traces.



# **ON Semiconductor®**

http://onsemi.com

# **40 VOLTS, 8.0 AMPS** NPN LOW $V_{CE(sat)}$ TRANSISTOR EQUIVALENT $R_{DS(on)}$ 31 m $\Omega$



# **ORDERING INFORMATION**

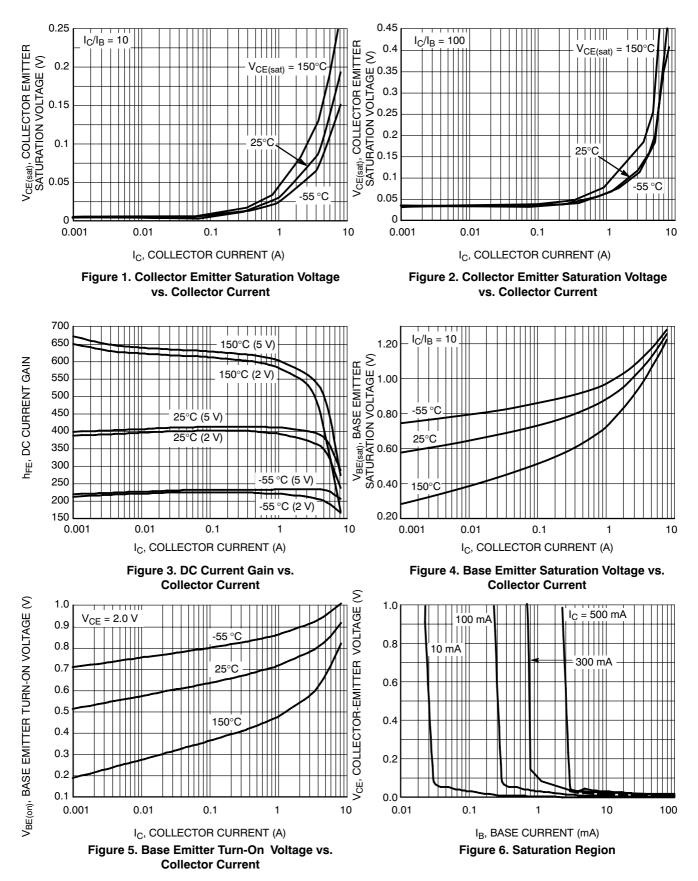
Device	Package	Shipping <sup>†</sup>
NSS40601CF8T1G	ChipFET (Pb-Free)	3000/ Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = $25^{\circ}$ C unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS				•	
Collector-Emitter Breakdown Voltage $(I_C = 10 \text{ mAdc}, I_B = 0)$	V <sub>(BR)CEO</sub>	40	-	-	Vdc
Collector-Base Breakdown Voltage $(I_C = 0.1 \text{ mAdc}, I_E = 0)$	V <sub>(BR)CBO</sub>	40	-	-	Vdc
Emitter-Base Breakdown Voltage $(I_E = 0.1 \text{ mAdc}, I_C = 0)$	V <sub>(BR)EBO</sub>	6.0	-	-	Vdc
Collector Cutoff Current ( $V_{CB} = 40 \text{ Vdc}, I_E = 0$ )	I <sub>CBO</sub>	-	-	0.1	μAdc
Emitter Cutoff Current (V <sub>EB</sub> = 6.0 Vdc)	I <sub>EBO</sub>	-	-	0.1	μAdc
ON CHARACTERISTICS					
$ \begin{array}{l} \text{DC Current Gain (Note 3)} \\ (I_{C} = 10 \text{ mA}, V_{CE} = 2.0 \text{ V}) \\ (I_{C} = 500 \text{ mA}, V_{CE} = 2.0 \text{ V}) \\ (I_{C} = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V}) \\ (I_{C} = 2.0 \text{ A}, V_{CE} = 2.0 \text{ V}) \\ (I_{C} = 3.0 \text{ A}, V_{CE} = 2.0 \text{ V}) \end{array} $	h <sub>FE</sub>	200 200 200 200 200	- - 395 - -	- - - - -	
	V <sub>CE(sat)</sub>	- - - - -	0.008 0.031 0.060 0.075 0.100 0.090	0.010 0.075 0.075 0.110 0.150 0.135	V
Base-Emitter Saturation Voltage (Note 3) $(I_C = 1.0 \text{ A}, I_B = 0.01 \text{ A})$	V <sub>BE(sat)</sub>	-	0.760	0.900	V
Base-Emitter Turn-on Voltage (Note 3) $(I_C = 2.0 \text{ A}, V_{CE} = 2.0 \text{ V})$	V <sub>BE(on)</sub>	-	0.720	0.900	V
Cutoff Frequency (I <sub>C</sub> = 100 mA, V <sub>CE</sub> = 5.0 V, f = 100 MHz)	f <sub>T</sub>	140	-	-	MHz
Input Capacitance (V <sub>EB</sub> = 0.5 V, f = 1.0 MHz)	Cibo	-	-	1200	pF
Output Capacitance (V <sub>CB</sub> = 3.0 V, f = 1.0 MHz)	Cobo	-	-	100	pF
SWITCHING CHARACTERISTICS					
Delay (V <sub>CC</sub> = 30 V, I <sub>C</sub> = 750 mA, I <sub>B1</sub> = 15 mA)	t <sub>d</sub>	-	-	110	ns
Rise (V <sub>CC</sub> = 30 V, $I_C$ = 750 mA, $I_{B1}$ = 15 mA)	t <sub>r</sub>	-	-	130	ns
Storage (V <sub>CC</sub> = 30 V, $I_C$ = 750 mA, $I_{B1}$ = 15 mA)	t <sub>s</sub>	-	-	1400	ns
Fall (V <sub>CC</sub> = 30 V, I <sub>C</sub> = 750 mA, I <sub>B1</sub> = 15 mA)	t <sub>f</sub>	-	-	130	ns

3. Pulsed Condition: Pulse Width = 300  $\mu sec,$  Duty Cycle  $\leq$  2%.



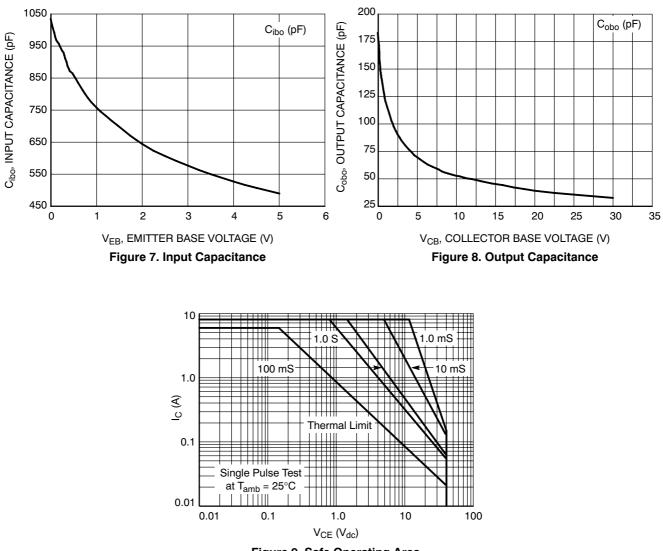


Figure 9. Safe Operating Area



**ChipFET**<sup>™</sup> CASE1206A-03 **ISSUE K** 

COLLECTOR

COLLECTOR COLLECTOR

4. BASE 5. EMITTER

2.

3.

6.

7. 8.

#### DATE 19 MAY 2009

INCHES

NOM

0.041

0.012

0.006

0.120

0.065

0.025 BS0

0.022 BSC

0.014

NOM

0.075 0.079

MAX

0.043

0.014

0.008

0.122

0.067

0.017

MIN

0.039

0.010

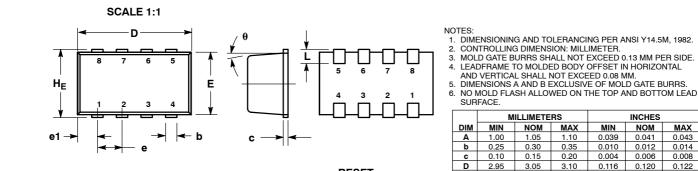
0.004

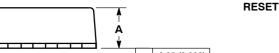
0.116

0.061

0.011

0.071





0.05 (0.002) STYLE 1: PIN 1. DRAIN 2. DRAIN STYLE 2: PIN 1 SOURCE 1 STYLE 3: STYLE 4: PIN 1. COLLECTOR PIN 1 DRAIN 2

З.

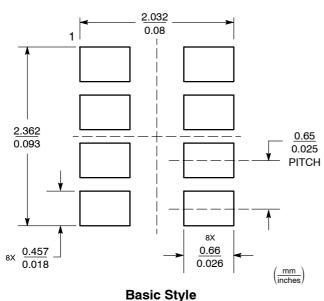
6. DRAIN

4. GATE 5. SOURCE

7. DRAIN 8. DRAIN

II. SOURCE I	PIN I. ANODE
2. GATE 1	2. ANODE
<ol><li>SOURCE 2</li></ol>	3. SOURCE
4. GATE 2	4. GATE
5. DRAIN 2	5. DRAIN
6. DRAIN 2	6. DRAIN
7. DRAIN 1	7. CATHODE
8. DRAIN 1	8. CATHODE

## SOLDERING FOOTPRINT



Η<sub>E</sub> θ 1.80 1.90 2.00 ' NON

MIN

2.95

1.55

0.28

Е

е

e1

T

MILLIMETERS

1.05

0.30

0.15

3.05

1.65

0.65 BS0

0.55 BSC

0.35

NOM MAX

1.10

0.35

0.20

3.10

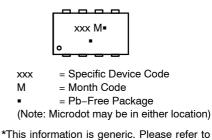
1.70

0.42

STYLE 5:	STYLE 6:
PIN 1. ANODE	PIN 1. ANODE
2. ANODE	2. DRAIN
3. DRAIN	3. DRAIN
4. DRAIN	4. GATE
5. SOURCE	5. SOURCE
6. GATE	6. DRAIN
<ol><li>CATHODE</li></ol>	7. DRAIN
<ol> <li>CATHODE</li> </ol>	8. CATHODE /

## GENERIC **MARKING DIAGRAM\***

DRAIN



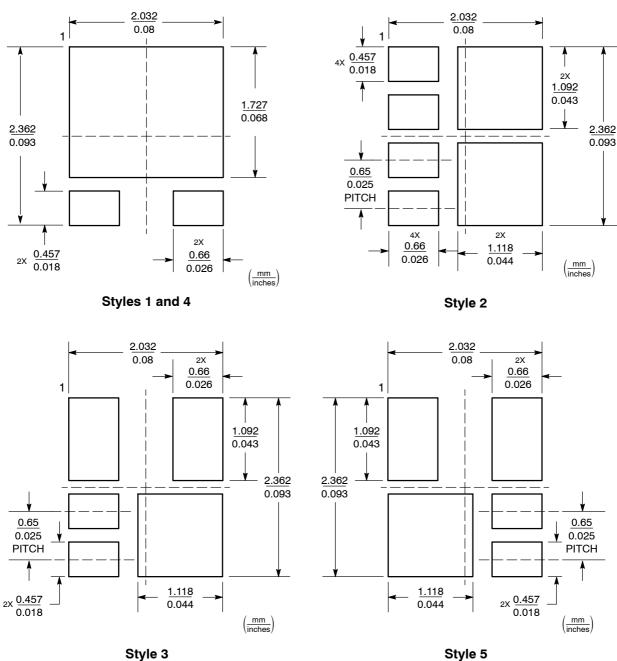
device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " .", may or may not be present.

# **OPTIONAL SOLDERING FOOTPRINTS ON PAGE 2**

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### ChipFET™ CASE 1206A-03 ISSUE K

DATE 19 MAY 2009



## **ADDITIONAL SOLDERING FOOTPRINTS\***

Style 3

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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